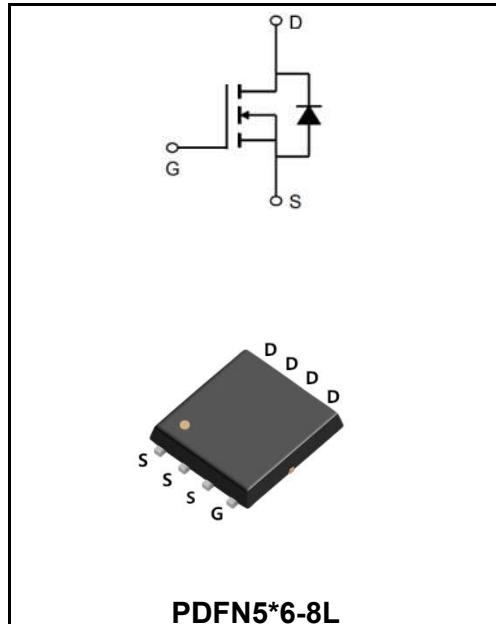


40V N-CHANNEL ENHANCEMENT MODE MOSFET
MAIN CHARACTERISTICS

| | |
|-------------------------------|----------------------|
| I_D | 65A |
| V_{DSS} | 40V |
| $R_{DS(on)-typ}(@V_{GS}=10V)$ | < 9mΩ (Type: 7.7 mΩ) |


Application

- Battery protection
- Load switch
- Uninterruptible power supply

Product Specification Classification

| Part Number | Package | Marking | Pack |
|-------------|------------|-------------------|--------------|
| YFW65N04NF | PDFN5*6-8L | YFW 65N04NF XXXXX | 5000PCS/Tape |

Maximum Ratings at $T_c=25^\circ\text{C}$ unless otherwise specified

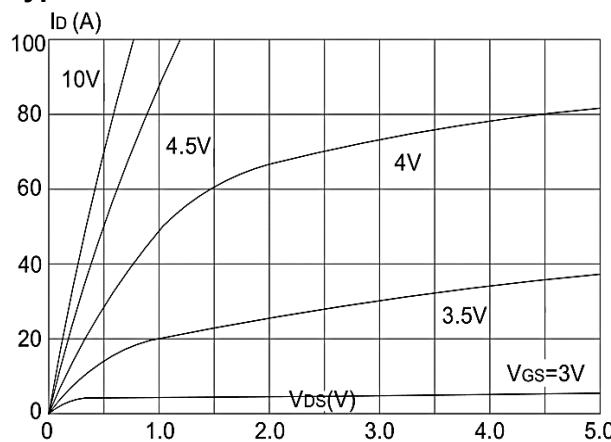
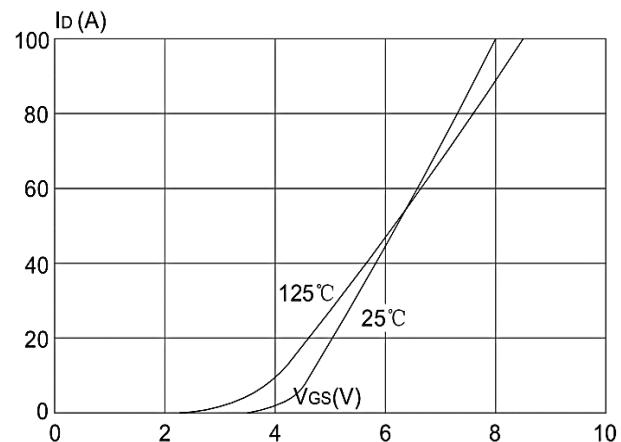
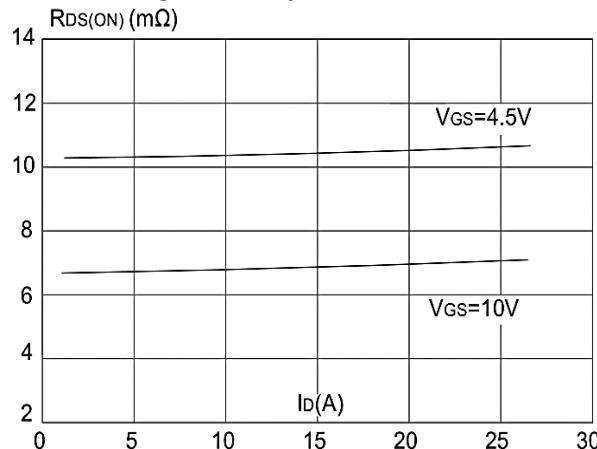
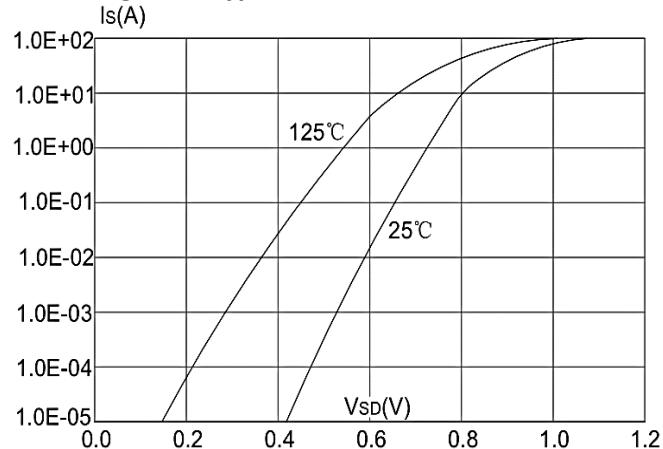
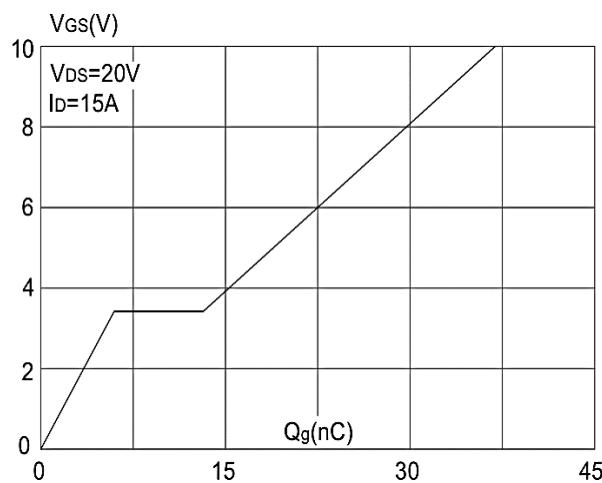
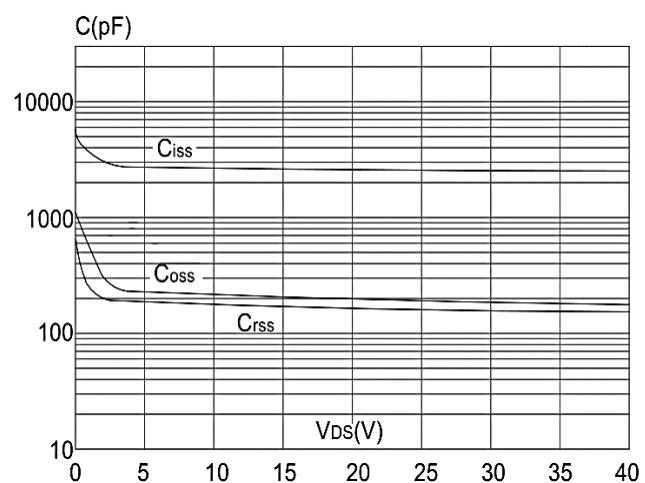
| Characteristics | Symbols | Value | Units |
|--|-----------------|-------------|-------|
| Drain-Source Voltage | V_{DS} | 40 | V |
| Gate - Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current, $V_{GS} @ 10V^1$ @ $T_c=25^\circ\text{C}$ | I_D | 65 | A |
| Continuous Drain Current, $V_{GS} @ 10V^1$ @ $T_c=100^\circ\text{C}$ | I_D | 33 | A |
| Pulsed Drain Current ² | I_{DM} | 200 | A |
| Single Pulse Avalanche Energy ³ | E_{AS} | 81 | mJ |
| Avalanche Current | I_{AS} | 10 | A |
| Total Power Dissipation ⁴ @ $T_c=25^\circ\text{C}$ | P_D | 33.7 | W |
| Total Power Dissipation ⁴ @ $T_A=25^\circ\text{C}$ | P_D | 2 | W |
| Storage Temperature Range | T_{STG} | -55 to +150 | °C |
| Operating Junction Temperature Range | T_J | -55 to +150 | °C |
| Thermal Resistance Junction-Ambient ¹ | $R_{\theta JA}$ | 3.7 | °C/W |
| Thermal Resistance Junction-Case ¹ | $R_{\theta JC}$ | 2.1 | °C/W |

Maximum Ratings at T_c=25°C unless otherwise specified

| Characteristics | Test Condition | Symbols | Min | Typ | Max | Units |
|---|---|------------------------|-----|-------|------|-------|
| Drain-Source Breakdown Voltage | V _{GS} =0V, I _D =250uA | BV _{DSS} | 40 | - | - | V |
| BVDSS Temperature Coefficient | Reference to 25°C , I _D =1mA | ΔBV _{DSS/ΔTJ} | - | 0.028 | - | V/°C |
| Static Drain-Source On-Resistance | V _{GS} =10V, I _D =30A | R _{DS(ON)} | - | 7.7 | 9.0 | mΩ |
| | V _{GS} =4.5V, I _D =15A | | - | 9.4 | 12 | |
| Gate -Threshold Voltage | V _{DS} =V _{GS} , I _D =250uA | V _{GS(th)} | 1.2 | 1.6 | 2.5 | V |
| V _{GS(th)} Temperature Coefficient | | ΔV _{GS(th)} | - | -6.16 | - | mV/°C |
| Drain -Source Leakage Current | V _{DS} =40V , V _{GS} =0V , T _J =25°C | I _{DSS} | - | - | 1 | μA |
| | V _{DS} =40V , V _{GS} =0V , T _J =55°C | | - | - | 5 | |
| Gate-Source Leakage Current | V _{GS} =±20V, V _{DS} =0V | I _{GSS} | - | - | ±100 | nA |
| Forward Transconductance | V _{DS} =5V, I _D =30A | g _{FS} | - | 22 | - | S |
| Gate Resistance | V _{DS} =0V , V _{GS} =0V , f=1MHz | R _g | - | 1.7 | 3.4 | Ω |
| Total Gate Charge(4.5V) | V _{DS} =20V V _{GS} =10V I _D =25A | Q _g | - | 37 | - | nC |
| Gate-Source Charge | | Q _{gs} | - | 6 | - | |
| Gate-Drain Charge | | Q _{gd} | - | 7 | - | |
| Turn-on delay time | V _{DD} =30V V _{GS} =10V R _G =1Ω I _D =25A | t _{d(on)} | - | 12 | - | ns |
| Rise Time | | T _r | - | 12 | - | |
| Turn-Off Delay Time | | t _{d(OFF)} | - | 38 | - | |
| Fall Time | | t _f | - | 9 | - | |
| Input Capacitance | V _{DS} =20V V _{GS} =0V f=1.0MHz | C _{iss} | - | 2400 | - | pF |
| Output Capacitance | | C _{oss} | - | 192 | - | |
| Reverse Transfer Capacitance | | C _{rss} | - | 165 | - | |
| Continuous Source Current ^{1,5} | V _G =V _D =0V , Force Current | I _s | - | - | 50 | A |
| Pulsed Source Current ^{2,5} | | I _{SM} | - | - | 200 | A |
| Diode Forward Voltage ² | V _{GS} =0V , I _s =1A , T _J =25°C | V _{SD} | - | - | 1.2 | V |
| Reverse Recovery Time | I _F =30A , dI/dt=100A/μs , T _J =25°C | t _{rr} | - | 22 | - | ns |
| Reverse Recovery Charge | | Q _{rr} | - | 11 | - | nC |

Note :

1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
2. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
3. The EAS data shows Max. rating . The test condition is VDD=36V,VGS =10V,L=0.1mH,IAS =10A
4. The power dissipation is limited by 150°C junction temperature
5. The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation

Ratings and Characteristic Curves
Typical Characteristics

Figure 1: Output Characteristics

Figure 2: Typical Transfer Characteristics

Figure 3: On-resistance vs. Drain Current

Figure 4: Body Diode Characteristics

Figure 5: Gate Charge Characteristics

Figure 6: Capacitance Characteristics

Ratings and Characteristic Curves

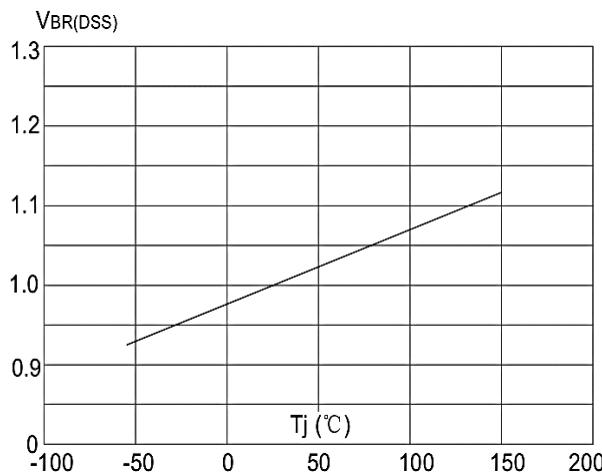


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

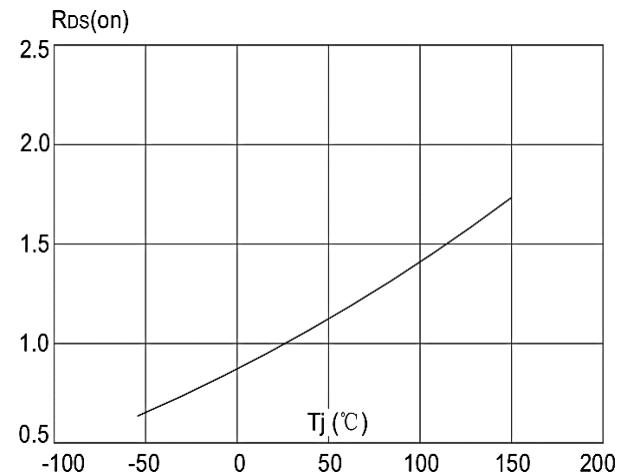


Figure 8: Normalized on Resistance vs. Junction Temperature

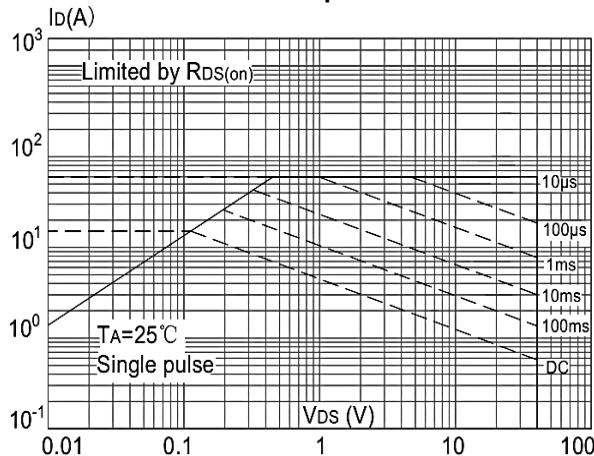


Figure 9: Maximum Safe Operating Area vs. Case Temperature

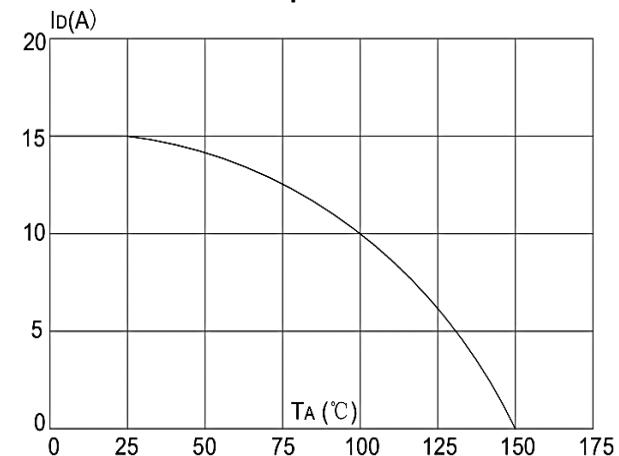


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

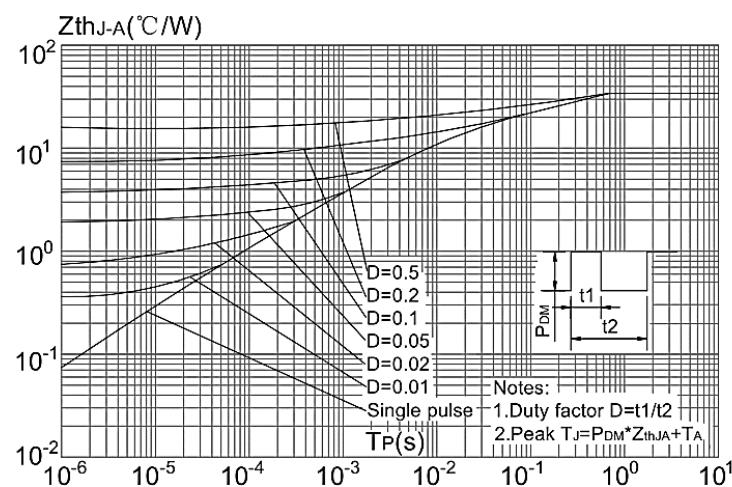
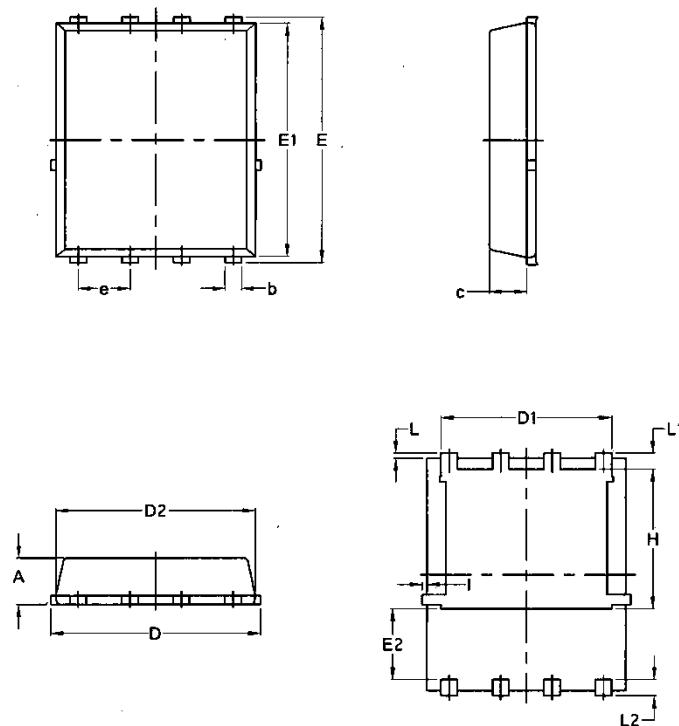


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

Package Outline Dimensions Millimeters
PDFN5*6-8L


| Symbol | Common | | | |
|--------|----------|--------|----------|--------|
| | mm | | Inch | |
| | Mim | Max | Min | Max |
| A | 1.03 | 1.17 | 0.0406 | 0.0461 |
| b | 0.34 | 0.48 | 0.0134 | 0.0189 |
| c | 0.824 | 0.0970 | 0.0324 | 0.082 |
| D | 4.80 | 5.40 | 0.1890 | 0.2126 |
| D1 | 4.11 | 4.31 | 0.1618 | 0.1697 |
| D2 | 4.80 | 5.00 | 0.1890 | 0.1969 |
| E | 5.95 | 6.15 | 0.2343 | 0.2421 |
| E1 | 5.65 | 5.85 | 0.2224 | 0.2303 |
| E2 | 1.60 | / | 0.0630 | / |
| e | 1.27 BSC | | 0.05 BSC | |
| L | 0.05 | 0.25 | 0.0020 | 0.0098 |
| L1 | 0.38 | 0.50 | 0.0150 | 0.0197 |
| L2 | 0.38 | 0.50 | 0.0150 | 0.0197 |
| H | 3.30 | 3.50 | 0.1299 | 0.1378 |
| I | / | 0.18 | / | 0.0070 |